

NTP52N10G-VB Datasheet N-Channel 100-V (D-S) MOSFET

PRODUCT	SUMMARY	
V _{(BR)DSS} (V)	r _{DS(on)} (Ω)	I _D (A)
100	0.017 at V _{GS} = 10 V	70 ^a

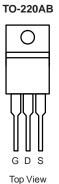
FEATURES

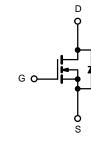
- TrenchFET[®] Power MOSFET
- 175 °C Junction Temperature
- Low Thermal Resistance Package
- 100 % R_g Tested

APPLICATIONS

• Isolated DC/DC Converters







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	T _C = 25 °C, unless oth	erwise noted		
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	100	V
Gate-Source Voltage		V _{GS}	± 20	- V
Continuous Drain Current ($T_1 = 175 \text{ °C}$)	T _C = 25 °C	I	70 ^a	
Continuous Drain Current (1j = 175 C)	T _C = 125 °C	D	35 ^a	A
Pulsed Drain Current		I _{DM}	145	~
Avalanche Current	L = 0.1 mH	I _{AS}	31	
Single Pulse Avalanche Energy ^b	L = 0.11111	E _{AS}	60	mJ
Mauiaum Daura Diasia stia sh	T _C = 25 °C	D_	355 ^c	w
Maximum Power Dissipation ^b	T _A = 25 °C ^d	– P _D –	3.35	vv
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 175	°C

THERMAL RESISTANCE	RATINGS			
Parameter		Symbol	Limit	Unit
Junction-to-Ambient	PCB Mount	R _{thJA}	40	°C/W
Junction-to-Case (Drain)		R _{thJC}	0.4	C/W

Notes:

- a. Package limited.
- b. Duty cycle \leq 1 %.
- c. See SOA curve for voltage derating.

d. When Mounted on 1" square PCB (FR-4 material).

SPECIFICATIONS $T_J = 25^{\circ}$ Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static	Symbol	Test conditions	IVIIII.	тур.	IVIAX.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{DS} = 0 V, I _D = 250 μA	100			
Gate-Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2		4	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, \text{ V}_{GS} = \pm 20 \text{ V}$	2		+ ± 100	nΔ
Gale-Dody Leakage	'GSS	$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			± 100	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 \text{ °C}$			50	ıιΔ
Zero Gale voltage Drain Gurrent	'DSS	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 175 \text{ °C}$			250	μΛ
On-State Drain Current ^a		$V_{DS} \ge 5 V, V_{GS} = 10 V$	120		200	Δ
	I _{D(on)}	$V_{GS} = 10 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	120	0.017		~
	r	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 30 \text{ A}$ $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 30 \text{ A}, \text{ T}_{J} = 125 \text{ °C}$		-		0
Drain-Source On-State Resistance ^a	r _{DS(on)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 30 \text{ A}, \text{ T}_{J} = 123 \text{ C}$ $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 30 \text{ A}, \text{ T}_{J} = 175 \text{ °C}$		0.023		nA μA Α Ω S PF nC Ω ns
	-			0.037		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 30 A	25			S
Dynamic ^b			-	L	I	1
Input Capacitance	C _{iss}			1800		nA μA Α Ω S PF nC
Output Capacitance	C _{oss}	$V_{GS} = 0 V$, $V_{DS} = 25 V$, f = 1 MHz		210		
Reverse Transfer Capacitance	C _{rss}			110		
Total Gate Charge ^c	Qg			90		
Gate-Source Charge ^c	Q _{gs}	$V_{DS} = 100 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 58 \text{ A}$		23		nC
Gate-Drain Charge ^c	Q _{gd}			34		
Gate Resistance	Rg		0.5	1.3	3.1	Ω
Turn-On Delay Time ^c	t _{d(on)}			24	35	
Rise Time ^c	t _r	V_{DD} = 100 V, R _L = 1.5 Ω		220	330	
Turn-Off Delay Time ^c	t _{d(off)}	$I_D \cong 58$ A, V_{GEN} = 10 V, R_g = 2.5		45	70	ns
Fall Time ^c	t _f	Ω		200	300	
Source-Drain Diode Ratings and Cha	aracteristics 7	Γ _C = 25 °C ^b		•		
Continuous Current	ا _S				70	
Pulsed Current	I _{SM}			115		A
Forward Voltage ^a	V _{SD}	I _F = 58 A, V _{GS} = 0 V		1.0	1.5	V
Reverse Recovery Time	t _{rr}			130	200	ns
Peak Reverse Recovery Current	I _{RM(REC)}	I _F = 30 A, di/dt = 100 A/µs		8	12	А
Reverse Recovery Charge	Q _{rr}			0.52	1.2	μC

Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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- 55 °C

7

6

5

T_C = 125 °C

4

 $V_{GS} = 10 V$

80

100

120

60

I_D - Drain Current (A)

40

50

75

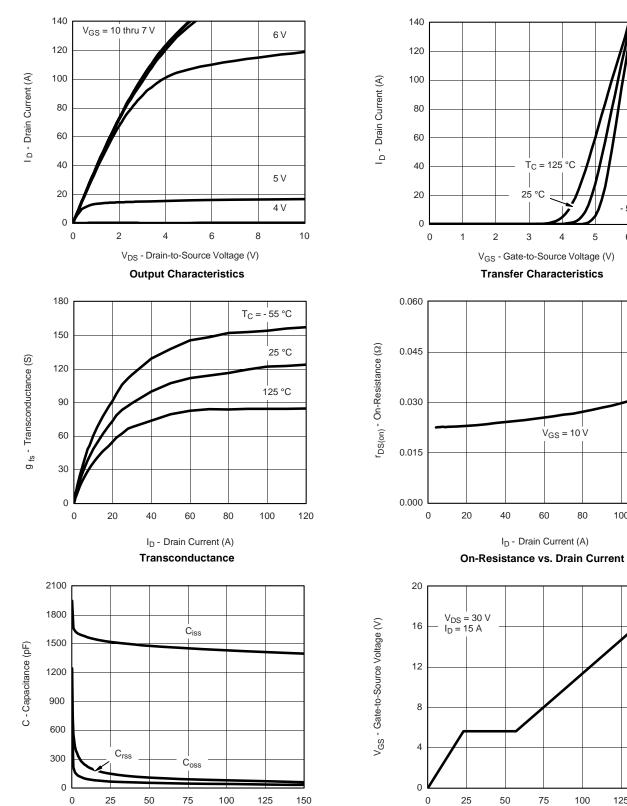
Q_q - Total Gate Charge (nC)

Gate Charge

100

25 °C

3



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



V_{DS} - Drain-to-Source Voltage (V)

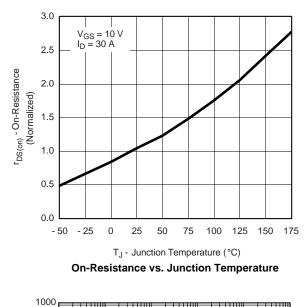
Capacitance

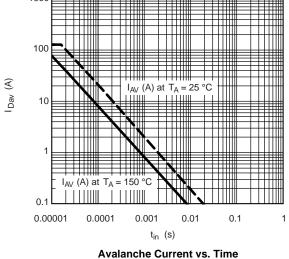
125

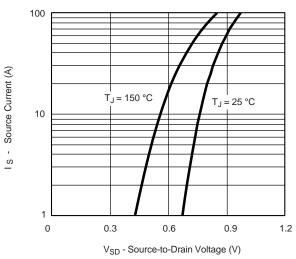
150



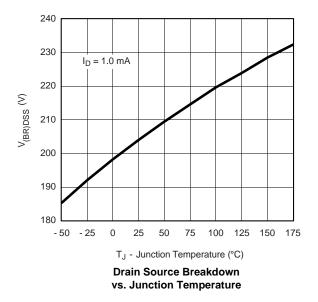
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





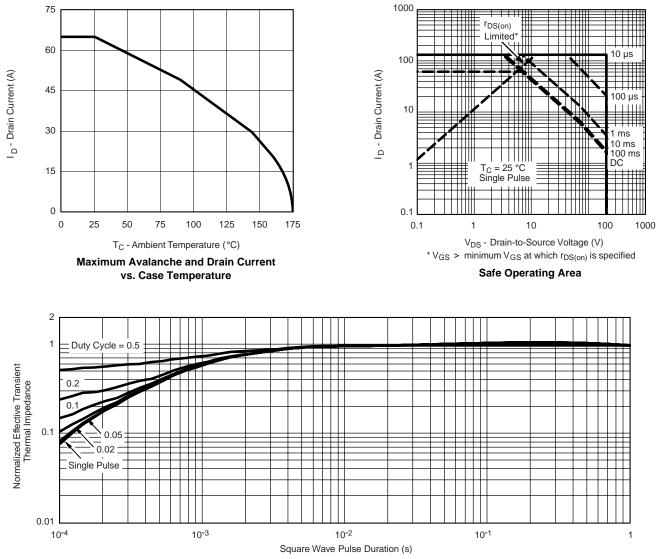


Source-Drain Diode Forward Voltage





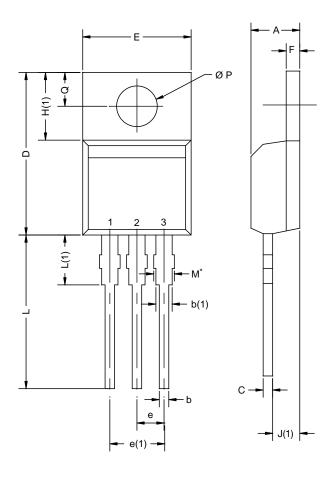
THERMAL RATINGS



Normalized Thermal Transient Impedance, Junction-to-Case



TO-220AB



DIM.	MILLIN	IETERS	INCHES		
	MIN.	MAX.	MIN.	MAX	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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